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#### What is "[Embedded - Microcontrollers](#)"?

"[Embedded - Microcontrollers](#)" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

#### Applications of "[Embedded - Microcontrollers](#)"

##### Details

Product Status	Not For New Designs
Core Processor	ARM® Cortex®-M4
Core Size	32-Bit Single-Core
Speed	100MHz
Connectivity	CANbus, EBI/EMI, I²C, IrDA, SD, SPI, UART/USART, USB, USB OTG
Peripherals	DMA, I²S, LVD, POR, PWM, WDT
Number of I/O	86
Program Memory Size	512KB (512K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	128K x 8
Voltage - Supply (Vcc/Vdd)	1.71V ~ 3.6V
Data Converters	A/D 38x16b; D/A 2x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 105°C (TA)
Mounting Type	Surface Mount
Package / Case	121-LFBGA
Supplier Device Package	121-MAPBGA (8x8)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/nxp-semiconductors/mk20dn512zvmc10r">https://www.e-xfl.com/product-detail/nxp-semiconductors/mk20dn512zvmc10r</a>



# Table of Contents

1 Ordering parts.....	5	6 Peripheral operating requirements and behaviors.....	24
1.1 Determining valid orderable parts.....	5	6.1 Core modules.....	24
2 Part identification.....	5	6.1.1 Debug trace timing specifications.....	24
2.1 Description.....	5	6.1.2 JTAG electricals.....	24
2.2 Format.....	5	6.2 System modules.....	27
2.3 Fields.....	5	6.3 Clock modules.....	27
2.4 Example.....	6	6.3.1 MCG specifications.....	27
3 Terminology and guidelines.....	6	6.3.2 Oscillator electrical specifications.....	29
3.1 Definition: Operating requirement.....	6	6.3.3 32 kHz Oscillator Electrical Characteristics.....	32
3.2 Definition: Operating behavior.....	7	6.4 Memories and memory interfaces.....	32
3.3 Definition: Attribute.....	7	6.4.1 Flash electrical specifications.....	32
3.4 Definition: Rating.....	8	6.4.2 EzPort Switching Specifications.....	37
3.5 Result of exceeding a rating.....	8	6.4.3 Flexbus Switching Specifications.....	38
3.6 Relationship between ratings and operating requirements.....	8	6.5 Security and integrity modules.....	41
3.7 Guidelines for ratings and operating requirements.....	9	6.6 Analog.....	41
3.8 Definition: Typical value.....	9	6.6.1 ADC electrical specifications.....	41
3.9 Typical value conditions.....	10	6.6.2 CMP and 6-bit DAC electrical specifications.....	49
4 Ratings.....	11	6.6.3 12-bit DAC electrical characteristics.....	51
4.1 Thermal handling ratings.....	11	6.6.4 Voltage reference electrical specifications.....	54
4.2 Moisture handling ratings.....	11	6.7 Timers.....	55
4.3 ESD handling ratings.....	11	6.8 Communication interfaces.....	55
4.4 Voltage and current operating ratings.....	11	6.8.1 USB electrical specifications.....	55
5 General.....	12	6.8.2 USB DCD electrical specifications.....	56
5.1 AC electrical characteristics.....	12	6.8.3 USB VREG electrical specifications.....	56
5.2 Nonswitching electrical specifications.....	12	6.8.4 CAN switching specifications.....	57
5.2.1 Voltage and current operating requirements.....	13	6.8.5 DSPI switching specifications (limited voltage range).....	57
5.2.2 LVD and POR operating requirements.....	14	6.8.6 DSPI switching specifications (full voltage range).....	58
5.2.3 Voltage and current operating behaviors.....	14	6.8.7 Inter-Integrated Circuit Interface (I2C) timing.....	60
5.2.4 Power mode transition operating behaviors.....	16	6.8.8 UART switching specifications.....	61
5.2.5 Power consumption operating behaviors.....	17	6.8.9 SDHC specifications.....	61
5.2.6 EMC radiated emissions operating behaviors....	20	6.8.10 I2S switching specifications.....	62
5.2.7 Designing with radiated emissions in mind.....	21	6.9 Human-machine interfaces (HMI).....	65
5.2.8 Capacitance attributes.....	21	6.9.1 TSI electrical specifications.....	65
5.3 Switching specifications.....	21	7 Dimensions.....	66
5.3.1 Device clock specifications.....	21	7.1 Obtaining package dimensions.....	66
5.3.2 General switching specifications.....	21	8 Pinout.....	66
5.4 Thermal specifications.....	22	8.1 K20 Signal Multiplexing and Pin Assignments.....	66
5.4.1 Thermal operating requirements.....	22	8.2 K20 Pinouts.....	71
5.4.2 Thermal attributes.....	23		

## 3.4 Definition: Rating

A *rating* is a minimum or maximum value of a technical characteristic that, if exceeded, may cause permanent chip failure:

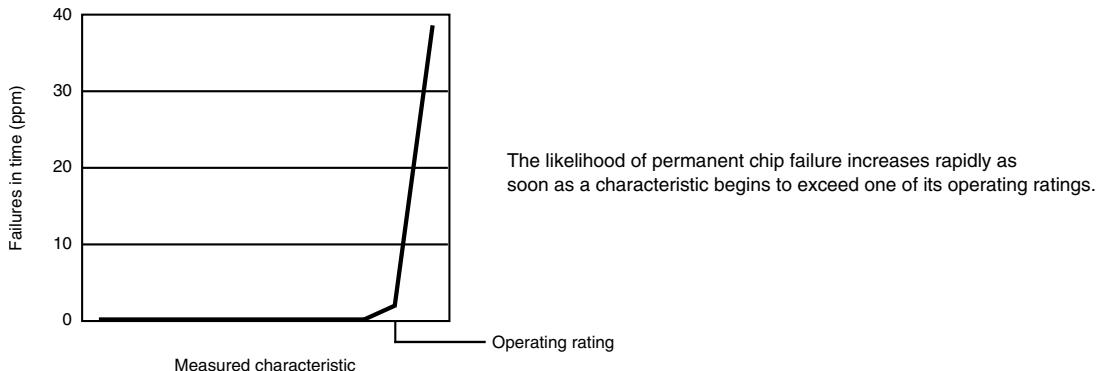
- *Operating ratings* apply during operation of the chip.
- *Handling ratings* apply when the chip is not powered.

### 3.4.1 Example

This is an example of an operating rating:

Symbol	Description	Min.	Max.	Unit
V <sub>DD</sub>	1.0 V core supply voltage	-0.3	1.2	V

## 3.5 Result of exceeding a rating



## 5.2 Nonswitching electrical specifications

### 5.2.1 Voltage and current operating requirements

**Table 1. Voltage and current operating requirements**

Symbol	Description	Min.	Max.	Unit	Notes
$V_{DD}$	Supply voltage	1.71	3.6	V	
$V_{DDA}$	Analog supply voltage	1.71	3.6	V	
$V_{DD} - V_{DDA}$	$V_{DD}$ -to- $V_{DDA}$ differential voltage	-0.1	0.1	V	
$V_{SS} - V_{SSA}$	$V_{SS}$ -to- $V_{SSA}$ differential voltage	-0.1	0.1	V	
$V_{BAT}$	RTC battery supply voltage	1.71	3.6	V	
$V_{IH}$	Input high voltage				
	• $2.7 \text{ V} \leq V_{DD} \leq 3.6 \text{ V}$	$0.7 \times V_{DD}$	—	V	
	• $1.7 \text{ V} \leq V_{DD} \leq 2.7 \text{ V}$	$0.75 \times V_{DD}$	—	V	
$V_{IL}$	Input low voltage				
	• $2.7 \text{ V} \leq V_{DD} \leq 3.6 \text{ V}$	—	$0.35 \times V_{DD}$	V	
	• $1.7 \text{ V} \leq V_{DD} \leq 2.7 \text{ V}$	—	$0.3 \times V_{DD}$	V	
$V_{HYS}$	Input hysteresis	$0.06 \times V_{DD}$	—	V	
$I_{ICDIO}$	Digital pin negative DC injection current — single pin	-5	—	mA	1
	• $V_{IN} < V_{SS}-0.3\text{V}$				
$I_{ICAIO}$	Analog <sup>2</sup> , EXTAL, and XTAL pin DC injection current — single pin			mA	3
	• $V_{IN} < V_{SS}-0.3\text{V}$ (Negative current injection)	-5	—		
	• $V_{IN} > V_{DD}+0.3\text{V}$ (Positive current injection)	—	+5		
$I_{ICcont}$	Contiguous pin DC injection current —regional limit, includes sum of negative injection currents or sum of positive injection currents of 16 contiguous pins			mA	
	• Negative current injection	-25	—		
	• Positive current injection	—	+25		
$V_{ODPU}$	Open drain pullup voltage level	$V_{DD}$	$V_{DD}$	V	4
$V_{RAM}$	$V_{DD}$ voltage required to retain RAM	1.2	—	V	
$V_{RFVBAT}$	$V_{BAT}$ voltage required to retain the VBAT register file	$V_{POR\_VBAT}$	—	V	

1. All 5 V tolerant digital I/O pins are internally clamped to  $V_{SS}$  through an ESD protection diode. There is no diode connection to  $V_{DD}$ . If  $V_{IN}$  is less than  $V_{DIO\_MIN}$ , a current limiting resistor is required. The negative DC injection current limiting resistor is calculated as  $R=(V_{DIO\_MIN}-V_{IN})/I_{ICDIO}$ .
2. Analog pins are defined as pins that do not have an associated general purpose I/O port function. Additionally, EXTAL and XTAL are analog pins.
3. All analog pins are internally clamped to  $V_{SS}$  and  $V_{DD}$  through ESD protection diodes. If  $V_{IN}$  is less than  $V_{AIO\_MIN}$  or greater than  $V_{AIO\_MAX}$ , a current limiting resistor is required. The negative DC injection current limiting resistor is calculated as  $R=(V_{AIO\_MIN}-V_{IN})/I_{ICAIO}$ . The positive injection current limiting resistor is calculated as  $R=(V_{IN}-V_{AIO\_MAX})/I_{ICAIO}$ . Select the larger of these two calculated resistances if the pin is exposed to positive and negative injection currents.
4. Open drain outputs must be pulled to VDD.

## 6.1.2 JTAG electricals

**Table 13. JTAG limited voltage range electricals**

Symbol	Description	Min.	Max.	Unit
	Operating voltage	2.7	3.6	V
J1	TCLK frequency of operation <ul style="list-style-type: none"> <li>• Boundary Scan</li> <li>• JTAG and CJTAG</li> <li>• Serial Wire Debug</li> </ul>	0	10	MHz
		0	25	
		0	50	
J2	TCLK cycle period	1/J1	—	ns
J3	TCLK clock pulse width <ul style="list-style-type: none"> <li>• Boundary Scan</li> <li>• JTAG and CJTAG</li> <li>• Serial Wire Debug</li> </ul>	50	—	ns
		20	—	ns
		10	—	ns
J4	TCLK rise and fall times	—	3	ns
J5	Boundary scan input data setup time to TCLK rise	20	—	ns
J6	Boundary scan input data hold time after TCLK rise	0	—	ns
J7	TCLK low to boundary scan output data valid	—	25	ns
J8	TCLK low to boundary scan output high-Z	—	25	ns
J9	TMS, TDI input data setup time to TCLK rise	8	—	ns
J10	TMS, TDI input data hold time after TCLK rise	1	—	ns
J11	TCLK low to TDO data valid	—	17	ns
J12	TCLK low to TDO high-Z	—	17	ns
J13	TRST assert time	100	—	ns
J14	TRST setup time (negation) to TCLK high	8	—	ns

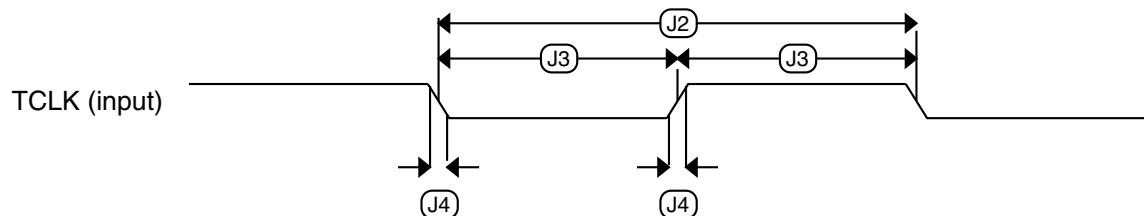
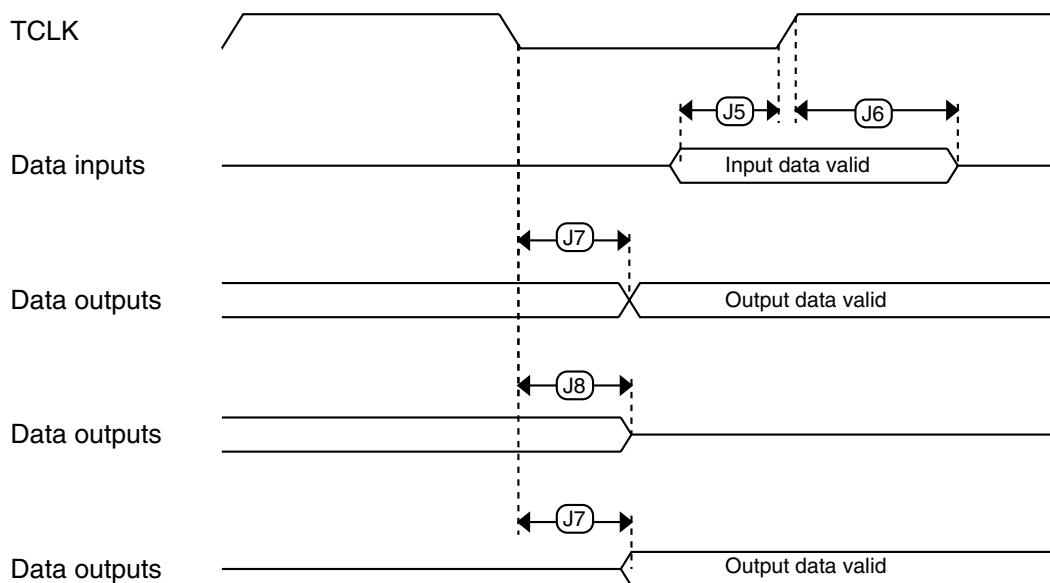
**Table 14. JTAG full voltage range electricals**

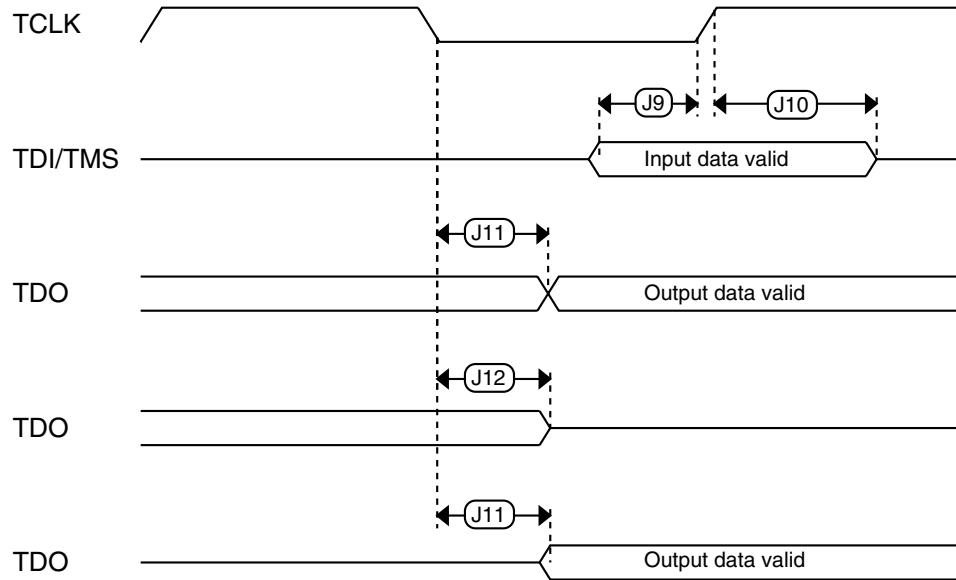
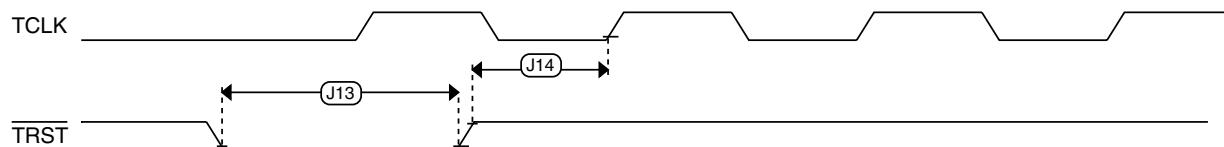
Symbol	Description	Min.	Max.	Unit
	Operating voltage	1.71	3.6	V
J1	TCLK frequency of operation <ul style="list-style-type: none"> <li>• Boundary Scan</li> <li>• JTAG and CJTAG</li> <li>• Serial Wire Debug</li> </ul>	0	10	MHz
		0	20	
		0	40	
J2	TCLK cycle period	1/J1	—	ns
J3	TCLK clock pulse width <ul style="list-style-type: none"> <li>• Boundary Scan</li> <li>• JTAG and CJTAG</li> <li>• Serial Wire Debug</li> </ul>	50	—	ns
		25	—	ns
		12.5	—	ns
J4	TCLK rise and fall times	—	3	ns

*Table continues on the next page...*

**Table 14. JTAG full voltage range electricals (continued)**

Symbol	Description	Min.	Max.	Unit
J5	Boundary scan input data setup time to TCLK rise	20	—	ns
J6	Boundary scan input data hold time after TCLK rise	0	—	ns
J7	TCLK low to boundary scan output data valid	—	25	ns
J8	TCLK low to boundary scan output high-Z	—	25	ns
J9	TMS, TDI input data setup time to TCLK rise	8	—	ns
J10	TMS, TDI input data hold time after TCLK rise	1.4	—	ns
J11	TCLK low to TDO data valid	—	22.1	ns
J12	TCLK low to TDO high-Z	—	22.1	ns
J13	TRST assert time	100	—	ns
J14	TRST setup time (negation) to TCLK high	8	—	ns

**Figure 5. Test clock input timing****Figure 6. Boundary scan (JTAG) timing**

**Figure 7. Test Access Port timing****Figure 8. TRST timing**

## 6.2 System modules

There are no specifications necessary for the device's system modules.

## 6.3 Clock modules

### 6.3.1 MCG specifications

Table 15. MCG specifications

Symbol	Description	Min.	Typ.	Max.	Unit	Notes
$f_{ints\_ft}$	Internal reference frequency (slow clock) — factory trimmed at nominal VDD and 25 °C	—	32.768	—	kHz	
$f_{ints\_t}$	Internal reference frequency (slow clock) — user trimmed — over fixed voltage and temperature range of 0–70°C	31.25	—	38.2	kHz	
$\Delta f_{dco\_res\_t}$	Resolution of trimmed average DCO output frequency at fixed voltage and temperature — using SCTRIM and SCFTRIM	—	± 0.3	± 0.6	% $f_{dco}$	1
$\Delta f_{dco\_t}$	Total deviation of trimmed average DCO output frequency over fixed voltage and temperature range of 0–70°C	—	± 1.5	± 4.5	% $f_{dco}$	1
$f_{intf\_ft}$	Internal reference frequency (fast clock) — factory trimmed at nominal VDD and 25°C	—	4	—	MHz	
$f_{intf\_t}$	Internal reference frequency (fast clock) — user trimmed at nominal VDD and 25 °C	3	—	5	MHz	
$f_{loc\_low}$	Loss of external clock minimum frequency — RANGE = 00	(3/5) x $f_{ints\_t}$	—	—	kHz	
$f_{loc\_high}$	Loss of external clock minimum frequency — RANGE = 01, 10, or 11	(16/5) x $f_{ints\_t}$	—	—	kHz	
<b>FLL</b>						
$f_{fill\_ref}$	FLL reference frequency range	31.25	—	39.0625	kHz	
$f_{dco}$	DCO output frequency range	Low range (DRS=00) 640 x $f_{fill\_ref}$	20	20.97	25	MHz
		Mid range (DRS=01) 1280 x $f_{fill\_ref}$	40	41.94	50	MHz
		Mid-high range (DRS=10) 1920 x $f_{fill\_ref}$	60	62.91	75	MHz
		High range (DRS=11) 2560 x $f_{fill\_ref}$	80	83.89	100	MHz
$f_{dco\_t\_DMX32}$	DCO output frequency	Low range (DRS=00) 732 x $f_{fill\_ref}$	—	23.99	—	MHz
		Mid range (DRS=01) 1464 x $f_{fill\_ref}$	—	47.97	—	MHz
		Mid-high range (DRS=10) 2197 x $f_{fill\_ref}$	—	71.99	—	MHz
		High range (DRS=11) 2929 x $f_{fill\_ref}$	—	95.98	—	MHz
$J_{cyc\_fill}$	FLL period jitter		—	180	—	ps
	• $f_{VCO} = 48$ MHz • $f_{VCO} = 98$ MHz		—	150	—	
$t_{fill\_acquire}$	FLL target frequency acquisition time	—	—	1	ms	6

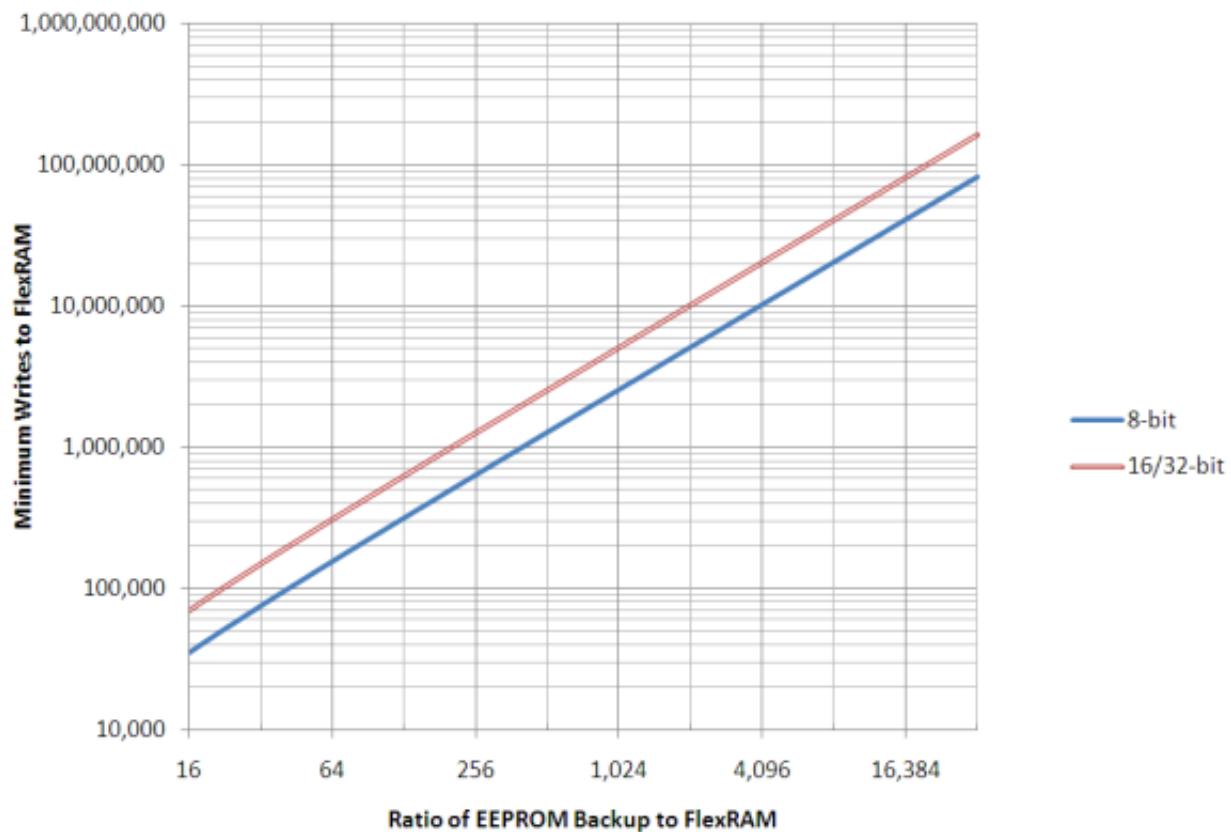
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### 6.3.2.1 Oscillator DC electrical specifications

Table 16. Oscillator DC electrical specifications

Symbol	Description	Min.	Typ.	Max.	Unit	Notes
$V_{DD}$	Supply voltage	1.71	—	3.6	V	
$I_{DDOSC}$	Supply current — low-power mode (HGO=0)	—	500	—	nA	1
	• 32 kHz	—	200	—	μA	
	• 4 MHz	—	300	—	μA	
	• 8 MHz (RANGE=01)	—	950	—	μA	
	• 16 MHz	—	1.2	—	mA	
	• 24 MHz	—	1.5	—	mA	
	• 32 MHz	—	—	—	—	
$I_{DDOSC}$	Supply current — high gain mode (HGO=1)	—	25	—	μA	1
	• 32 kHz	—	400	—	μA	
	• 4 MHz	—	500	—	μA	
	• 8 MHz (RANGE=01)	—	2.5	—	mA	
	• 16 MHz	—	3	—	mA	
	• 24 MHz	—	4	—	mA	
	• 32 MHz	—	—	—	—	
$C_x$	EXTAL load capacitance	—	—	—	—	2, 3
$C_y$	XTAL load capacitance	—	—	—	—	2, 3
$R_F$	Feedback resistor — low-frequency, low-power mode (HGO=0)	—	—	—	MΩ	2, 4
	Feedback resistor — low-frequency, high-gain mode (HGO=1)	—	10	—	MΩ	
	Feedback resistor — high-frequency, low-power mode (HGO=0)	—	—	—	MΩ	
	Feedback resistor — high-frequency, high-gain mode (HGO=1)	—	1	—	MΩ	
$R_S$	Series resistor — low-frequency, low-power mode (HGO=0)	—	—	—	kΩ	
	Series resistor — low-frequency, high-gain mode (HGO=1)	—	200	—	kΩ	
	Series resistor — high-frequency, low-power mode (HGO=0)	—	—	—	kΩ	
	Series resistor — high-frequency, high-gain mode (HGO=1)	—	0	—	kΩ	

Table continues on the next page...

**Figure 9. EEPROM backup writes to FlexRAM**

## 6.4.2 EzPort Switching Specifications

**Table 24. EzPort switching specifications**

Num	Description	Min.	Max.	Unit
	Operating voltage	1.71	3.6	V
EP1	EZP_CK frequency of operation (all commands except READ)	—	$f_{SYS}/2$	MHz
EP1a	EZP_CK frequency of operation (READ command)	—	$f_{SYS}/8$	MHz
EP2	EZP_CS negation to next EZP_CS assertion	$2 \times t_{Ezp\_CK}$	—	ns
EP3	EZP_CS input valid to EZP_CK high (setup)	5	—	ns
EP4	EZP_CK high to EZP_CS input invalid (hold)	5	—	ns
EP5	EZP_D input valid to EZP_CK high (setup)	2	—	ns
EP6	EZP_CK high to EZP_D input invalid (hold)	5	—	ns
EP7	EZP_CK low to EZP_Q output valid	—	16	ns
EP8	EZP_CK low to EZP_Q output invalid (hold)	0	—	ns
EP9	EZP_CS negation to EZP_Q tri-state	—	12	ns

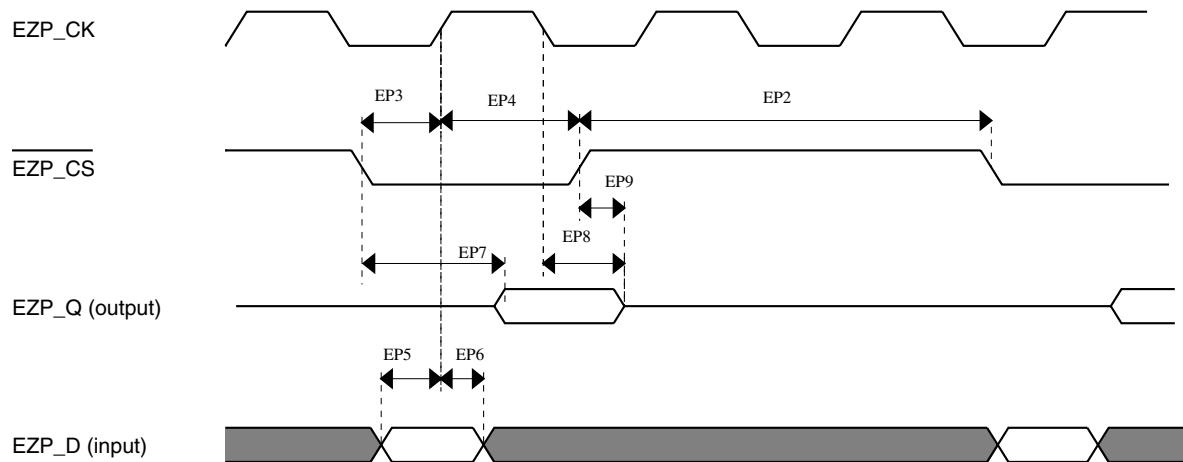


Figure 10. EzPort Timing Diagram

### 6.4.3 Flexbus Switching Specifications

All processor bus timings are synchronous; input setup/hold and output delay are given in respect to the rising edge of a reference clock, FB\_CLK. The FB\_CLK frequency may be the same as the internal system bus frequency or an integer divider of that frequency.

The following timing numbers indicate when data is latched or driven onto the external bus, relative to the Flexbus output clock (FB\_CLK). All other timing relationships can be derived from these values.

Table 25. Flexbus limited voltage range switching specifications

Num	Description	Min.	Max.	Unit	Notes
	Operating voltage	2.7	3.6	V	
	Frequency of operation	—	FB_CLK	MHz	
FB1	Clock period	20	—	ns	
FB2	Address, data, and control output valid	—	11.5	ns	<a href="#">1</a>
FB3	Address, data, and control output hold	0.5	—	ns	<a href="#">1</a>
FB4	Data and FB_TA input setup	8.5	—	ns	<a href="#">2</a>
FB5	Data and FB_TA input hold	0.5	—	ns	<a href="#">2</a>

1. Specification is valid for all FB\_AD[31:0], FB\_BE/BWEn, FB\_CSn, FB\_OE, FB\_R/W, FB\_TBST, FB\_TSIZ[1:0], FB\_ALE, and FB\_TS.

**Table 29. 16-bit ADC with PGA operating conditions (continued)**

Symbol	Description	Conditions	Min.	Typ. <sup>1</sup>	Max.	Unit	Notes
$C_{rate}$	ADC conversion rate	≤ 13 bit modes No ADC hardware averaging Continuous conversions enabled Peripheral clock = 50 MHz	18.484	—	450	Ksps	7
		16 bit modes No ADC hardware averaging Continuous conversions enabled Peripheral clock = 50 MHz	37.037	—	250	Ksps	8

1. Typical values assume  $V_{DDA} = 3.0$  V, Temp = 25°C,  $f_{ADCK} = 6$  MHz unless otherwise stated. Typical values are for reference only and are not tested in production.
2. ADC must be configured to use the internal voltage reference (VREF\_OUT)
3. PGA reference is internally connected to the VREF\_OUT pin. If the user wishes to drive VREF\_OUT with a voltage other than the output of the VREF module, the VREF module must be disabled.
4. For single ended configurations the input impedance of the driven input is  $R_{PGAD}/2$
5. The analog source resistance ( $R_{AS}$ ), external to MCU, should be kept as minimum as possible. Increased  $R_{AS}$  causes drop in PGA gain without affecting other performances. This is not dependent on ADC clock frequency.
6. The minimum sampling time is dependent on input signal frequency and ADC mode of operation. A minimum of 1.25μs time should be allowed for  $F_{in}=4$  kHz at 16-bit differential mode. Recommended ADC setting is: ADLSMP=1, ADLSTS=2 at 8 MHz ADC clock.
7. ADC clock = 18 MHz, ADLSMP = 1, ADLST = 00, ADHSC = 1
8. ADC clock = 12 MHz, ADLSMP = 1, ADLST = 01, ADHSC = 1

#### 6.6.1.4 16-bit ADC with PGA characteristics

**Table 30. 16-bit ADC with PGA characteristics**

Symbol	Description	Conditions	Min.	Typ. <sup>1</sup>	Max.	Unit	Notes
$I_{DDA\_PGA}$	Supply current	Low power (ADC_PGA[PGALPb]=0)	—	420	644	μA	2
$I_{DC\_PGA}$	Input DC current			$\frac{2}{R_{PGAD}} \left( \frac{(V_{REFPGA} \times 0.583) - V_{CM}}{(Gain+1)} \right)$	A		3
		Gain =1, $V_{REFPGA}=1.2V$ , $V_{CM}=0.5V$	—	1.54	—	μA	
		Gain =64, $V_{REFPGA}=1.2V$ , $V_{CM}=0.1V$	—	0.57	—	μA	

Table continues on the next page...

**Table 30. 16-bit ADC with PGA characteristics (continued)**

Symbol	Description	Conditions	Min.	Typ. <sup>1</sup>	Max.	Unit	Notes
ENOB	Effective number of bits	<ul style="list-style-type: none"> <li>Gain=1, Average=4</li> <li>Gain=64, Average=4</li> <li>Gain=1, Average=32</li> <li>Gain=2, Average=32</li> <li>Gain=4, Average=32</li> <li>Gain=8, Average=32</li> <li>Gain=16, Average=32</li> <li>Gain=32, Average=32</li> <li>Gain=64, Average=32</li> </ul>	11.6 7.2 12.8 11.0 7.9 7.3 6.8 6.8 7.5	13.4 9.6 14.5 14.3 13.8 13.1 12.5 11.5 10.6	— — — — — — — — —	bits bits bits bits bits bits bits bits bits	16-bit differential mode, $f_{in}=100\text{Hz}$
SINAD	Signal-to-noise plus distortion ratio	See ENOB	$6.02 \times \text{ENOB} + 1.76$			dB	

1. Typical values assume  $V_{DDA} = 3.0\text{V}$ , Temp=25°C,  $f_{ADCK}=6\text{MHz}$  unless otherwise stated.
2. This current is a PGA module adder, in addition to ADC conversion currents.
3. Between IN+ and IN-. The PGA draws a DC current from the input terminals. The magnitude of the DC current is a strong function of input common mode voltage ( $V_{CM}$ ) and the PGA gain.
4. Gain =  $2^{PGAG}$
5. After changing the PGA gain setting, a minimum of 2 ADC+PGA conversions should be ignored.
6. Limit the input signal swing so that the PGA does not saturate during operation. Input signal swing is dependent on the PGA reference voltage and gain setting.

## 6.6.2 CMP and 6-bit DAC electrical specifications

**Table 31. Comparator and 6-bit DAC electrical specifications**

Symbol	Description	Min.	Typ.	Max.	Unit
$V_{DD}$	Supply voltage	1.71	—	3.6	V
$I_{DDHS}$	Supply current, High-speed mode (EN=1, PMODE=1)	—	—	200	$\mu\text{A}$
$I_{DDLS}$	Supply current, low-speed mode (EN=1, PMODE=0)	—	—	20	$\mu\text{A}$
$V_{AIN}$	Analog input voltage	$V_{SS} - 0.3$	—	$V_{DD}$	V
$V_{AIO}$	Analog input offset voltage	—	—	20	mV
$V_H$	Analog comparator hysteresis <sup>1</sup> <ul style="list-style-type: none"> <li>CR0[HYSTCTR] = 00</li> <li>CR0[HYSTCTR] = 01</li> <li>CR0[HYSTCTR] = 10</li> <li>CR0[HYSTCTR] = 11</li> </ul>	— — — —	5 10 20 30	— — — —	mV mV mV mV
$V_{CMPOh}$	Output high	$V_{DD} - 0.5$	—	—	V
$V_{CMPOl}$	Output low	—	—	0.5	V
$t_{DHS}$	Propagation delay, high-speed mode (EN=1, PMODE=1)	20	50	200	ns

Table continues on the next page...

**Table 35. VREF full-range operating behaviors**

Symbol	Description	Min.	Typ.	Max.	Unit	Notes
$V_{out}$	Voltage reference output with factory trim at nominal $V_{DDA}$ and temperature=25C	1.1915	1.195	1.1977	V	
$V_{out}$	Voltage reference output — factory trim	1.1584	—	1.2376	V	
$V_{step}$	Voltage reference trim step	—	0.5	—	mV	
$V_{tdrift}$	Temperature drift (Vmax -Vmin across the full temperature range)	—	—	80	mV	
$I_{bg}$	Bandgap only current	—	—	80	$\mu A$	1
$I_{lp}$	Low-power buffer current	—	—	360	$\mu A$	1
$I_{hp}$	High-power buffer current	—	—	1	mA	1
$\Delta V_{LOAD}$	Load regulation <ul style="list-style-type: none"> <li>• current = + 1.0 mA</li> <li>• current = - 1.0 mA</li> </ul>	—	2	—	mV	1, 2
$T_{stup}$	Buffer startup time	—	—	100	$\mu s$	
$V_{vdrift}$	Voltage drift (Vmax -Vmin across the full voltage range)	—	2	—	mV	1

1. See the chip's Reference Manual for the appropriate settings of the VREF Status and Control register.
2. Load regulation voltage is the difference between the VREF\_OUT voltage with no load vs. voltage with defined load

**Table 36. VREF limited-range operating requirements**

Symbol	Description	Min.	Max.	Unit	Notes
$T_A$	Temperature	0	50	$^{\circ}C$	

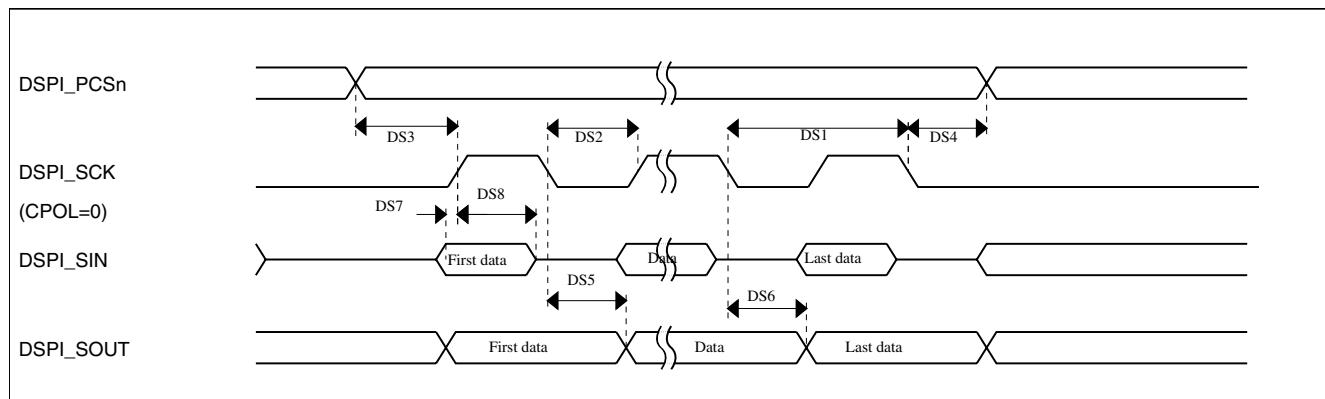
**Table 37. VREF limited-range operating behaviors**

Symbol	Description	Min.	Max.	Unit	Notes
$V_{out}$	Voltage reference output with factory trim	1.173	1.225	V	

## 6.7 Timers

See [General switching specifications](#).

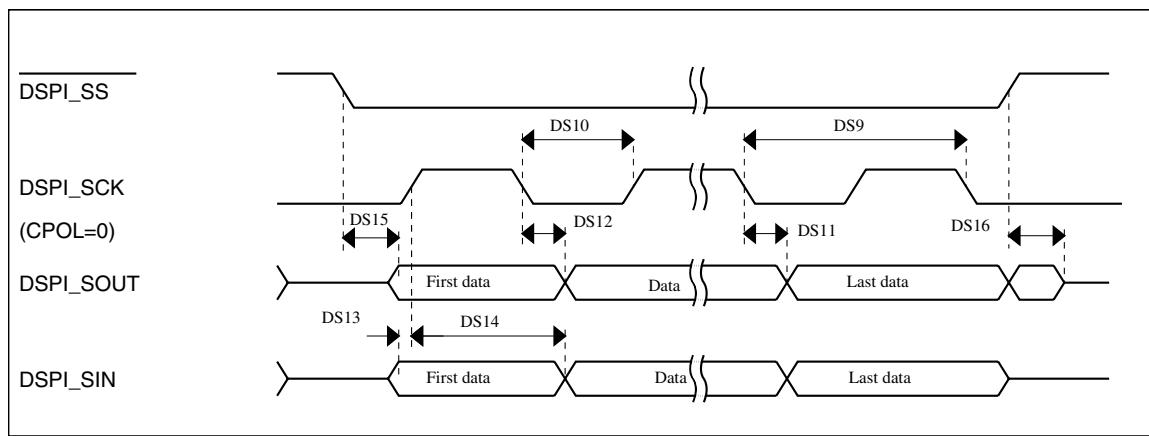
## 6.8 Communication interfaces



**Figure 20. DSPI classic SPI timing — master mode**

**Table 41. Slave mode DSPI timing (limited voltage range)**

Num	Description	Min.	Max.	Unit
	Operating voltage	2.7	3.6	V
	Frequency of operation		12.5	MHz
DS9	DSPI_SCK input cycle time	$4 \times t_{BUS}$	—	ns
DS10	DSPI_SCK input high/low time	$(t_{SCK}/2) - 2$	$(t_{SCK}/2) + 2$	ns
DS11	DSPI_SCK to DSPI_SOUT valid	—	10	ns
DS12	DSPI_SCK to DSPI_SOUT invalid	0	—	ns
DS13	DSPI_SIN to DSPI_SCK input setup	2	—	ns
DS14	DSPI_SCK to DSPI_SIN input hold	7	—	ns
DS15	DSPI_SS active to DSPI_SOUT driven	—	14	ns
DS16	DSPI_SS inactive to DSPI_SOUT not driven	—	14	ns



**Figure 21. DSPI classic SPI timing — slave mode**

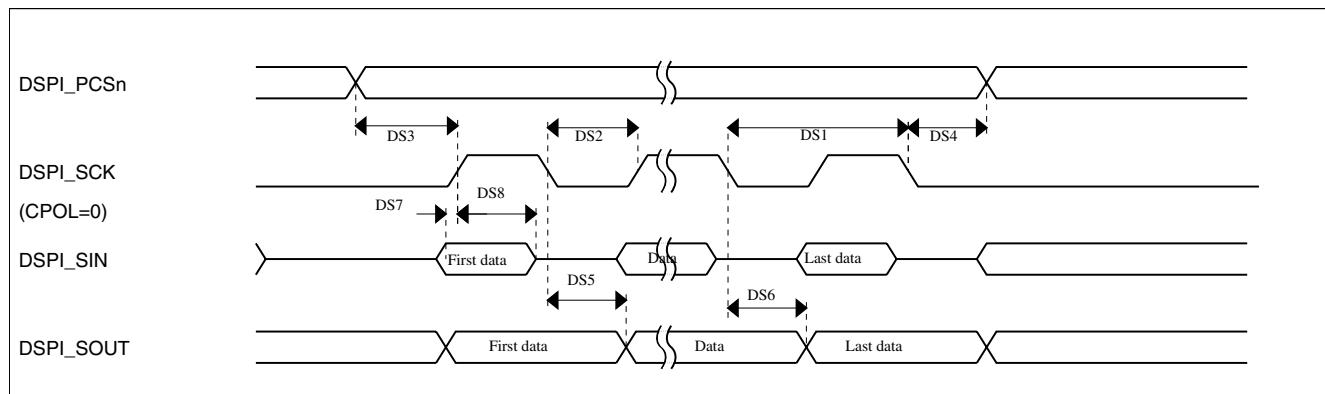
## 6.8.6 DSPI switching specifications (full voltage range)

The DMA Serial Peripheral Interface (DSPI) provides a synchronous serial bus with master and slave operations. Many of the transfer attributes are programmable. The tables below provides DSPI timing characteristics for classic SPI timing modes. Refer to the DSPI chapter of the Reference Manual for information on the modified transfer formats used for communicating with slower peripheral devices.

**Table 42. Master mode DSPI timing (full voltage range)**

Num	Description	Min.	Max.	Unit	Notes
	Operating voltage	1.71	3.6	V	<a href="#">1</a>
	Frequency of operation	—	12.5	MHz	
DS1	DSPI_SCK output cycle time	$4 \times t_{BUS}$	—	ns	
DS2	DSPI_SCK output high/low time	$(t_{SCK}/2) - 4$	$(t_{SCK}/2) + 4$	ns	
DS3	DSPI_PCSn valid to DSPI_SCK delay	$(t_{BUS} \times 2) - 4$	—	ns	<a href="#">2</a>
DS4	DSPI_SCK to DSPI_PCSn invalid delay	$(t_{BUS} \times 2) - 4$	—	ns	<a href="#">3</a>
DS5	DSPI_SCK to DSPI_SOUT valid	—	10	ns	
DS6	DSPI_SCK to DSPI_SOUT invalid	-4.5	—	ns	
DS7	DSPI_SIN to DSPI_SCK input setup	20.5	—	ns	
DS8	DSPI_SCK to DSPI_SIN input hold	0	—	ns	

1. The DSPI module can operate across the entire operating voltage for the processor, but to run across the full voltage range the maximum frequency of operation is reduced.
2. The delay is programmable in SPIx\_CTARn[PSSCK] and SPIx\_CTARn[CSSCK].
3. The delay is programmable in SPIx\_CTARn[PASC] and SPIx\_CTARn[ASC].



**Figure 22. DSPI classic SPI timing — master mode**

**Table 43. Slave mode DSPI timing (full voltage range)**

Num	Description	Min.	Max.	Unit
	Operating voltage	1.71	3.6	V
	Frequency of operation	—	6.25	MHz

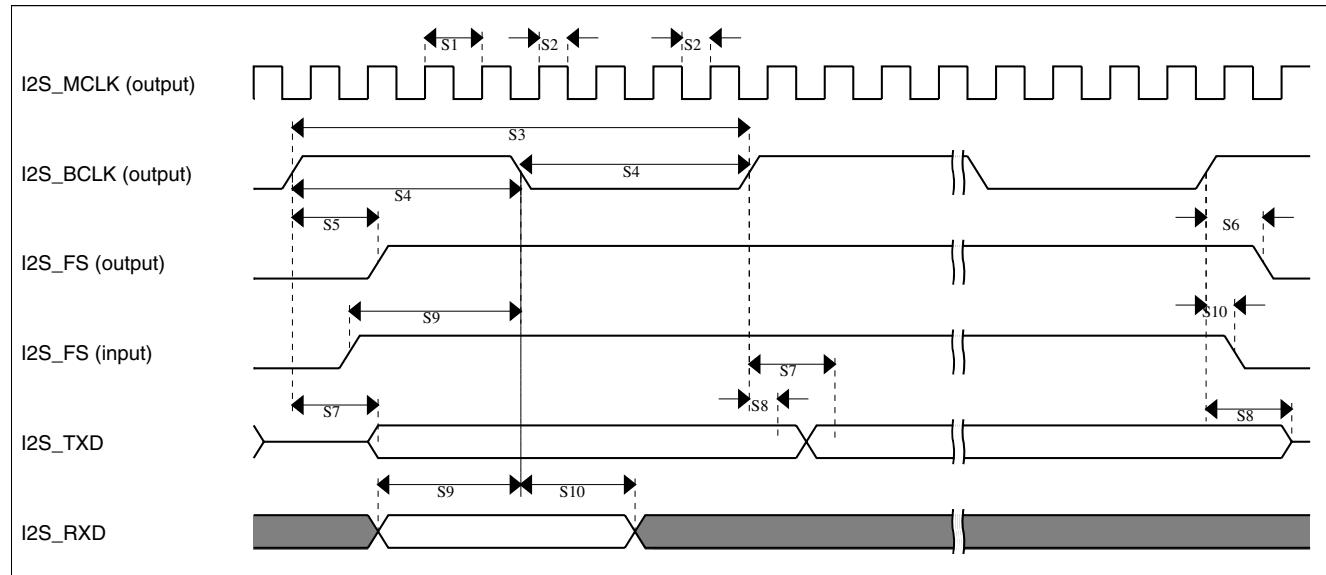
*Table continues on the next page...*

## 6.8.10 I<sup>2</sup>S switching specifications

This section provides the AC timings for the I<sup>2</sup>S in master (clocks driven) and slave modes (clocks input). All timings are given for non-inverted serial clock polarity (TCR[TSCKP] = 0, RCR[RSCKP] = 0) and a non-inverted frame sync (TCR[TFSI] = 0, RCR[RFSI] = 0). If the polarity of the clock and/or the frame sync have been inverted, all the timings remain valid by inverting the clock signal (I2S\_BCLK) and/or the frame sync (I2S\_FS) shown in the figures below.

**Table 46. I<sup>2</sup>S master mode timing (limited voltage range)**

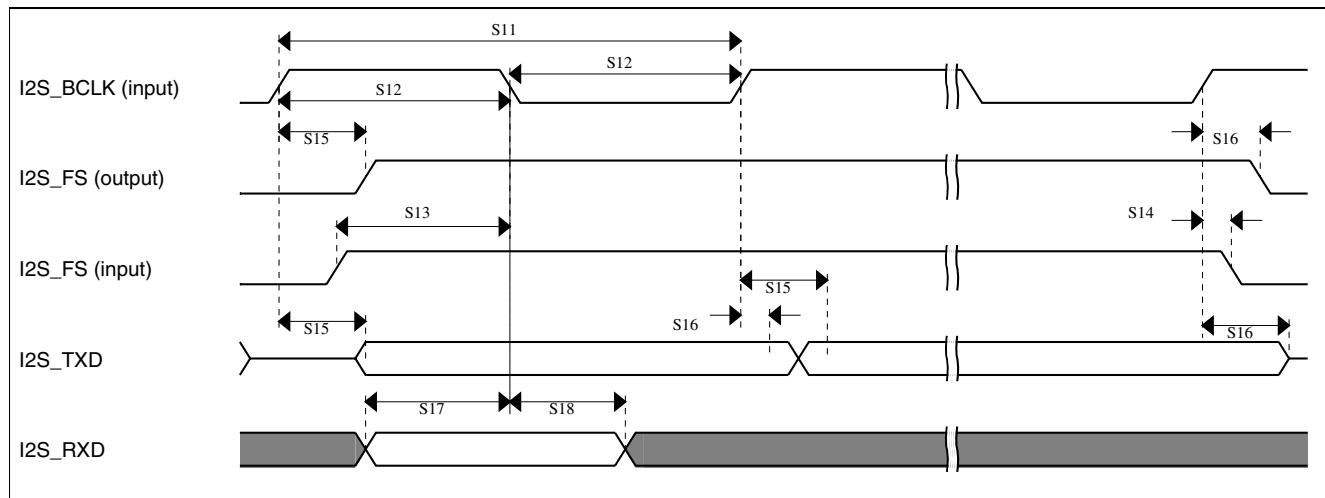
Num	Description	Min.	Max.	Unit
	Operating voltage	2.7	3.6	V
S1	I2S_MCLK cycle time	$2 \times t_{SYS}$		ns
S2	I2S_MCLK pulse width high/low	45%	55%	MCLK period
S3	I2S_BCLK cycle time	$5 \times t_{SYS}$	—	ns
S4	I2S_BCLK pulse width high/low	45%	55%	BCLK period
S5	I2S_BCLK to I2S_FS output valid	—	15	ns
S6	I2S_BCLK to I2S_FS output invalid	-2.5	—	ns
S7	I2S_BCLK to I2S_TXD valid	—	15	ns
S8	I2S_BCLK to I2S_TXD invalid	-3	—	ns
S9	I2S_RXD/I2S_FS input setup before I2S_BCLK	20	—	ns
S10	I2S_RXD/I2S_FS input hold after I2S_BCLK	0	—	ns



**Figure 26. I<sup>2</sup>S timing — master mode**

**Table 47. I<sup>2</sup>S slave mode timing (limited voltage range)**

Num	Description	Min.	Max.	Unit
	Operating voltage	2.7	3.6	V
S11	I <sup>2</sup> S_BCLK cycle time (input)	$8 \times t_{SYS}$	—	ns
S12	I <sup>2</sup> S_BCLK pulse width high/low (input)	45%	55%	MCLK period
S13	I <sup>2</sup> S_FS input setup before I <sup>2</sup> S_BCLK	10	—	ns
S14	I <sup>2</sup> S_FS input hold after I <sup>2</sup> S_BCLK	3	—	ns
S15	I <sup>2</sup> S_BCLK to I <sup>2</sup> S_TXD/I <sup>2</sup> S_FS output valid	—	20	ns
S16	I <sup>2</sup> S_BCLK to I <sup>2</sup> S_TXD/I <sup>2</sup> S_FS output invalid	0	—	ns
S17	I <sup>2</sup> S_RXD setup before I <sup>2</sup> S_BCLK	10	—	ns
S18	I <sup>2</sup> S_RXD hold after I <sup>2</sup> S_BCLK	2	—	ns

**Figure 27. I<sup>2</sup>S timing — slave modes****Table 48. I<sup>2</sup>S master mode timing (full voltage range)**

Num	Description	Min.	Max.	Unit
	Operating voltage	1.71	3.6	V
S1	I <sup>2</sup> S_MCLK cycle time	$2 \times t_{SYS}$	—	ns
S2	I <sup>2</sup> S_MCLK pulse width high/low	45%	55%	MCLK period
S3	I <sup>2</sup> S_BCLK cycle time	$5 \times t_{SYS}$	—	ns
S4	I <sup>2</sup> S_BCLK pulse width high/low	45%	55%	BCLK period
S5	I <sup>2</sup> S_BCLK to I <sup>2</sup> S_FS output valid	—	15	ns
S6	I <sup>2</sup> S_BCLK to I <sup>2</sup> S_FS output invalid	-4.3	—	ns
S7	I <sup>2</sup> S_BCLK to I <sup>2</sup> S_TXD valid	—	15	ns
S8	I <sup>2</sup> S_BCLK to I <sup>2</sup> S_TXD invalid	-4.6	—	ns
S9	I <sup>2</sup> S_RXD/I <sup>2</sup> S_FS input setup before I <sup>2</sup> S_BCLK	23.9	—	ns
S10	I <sup>2</sup> S_RXD/I <sup>2</sup> S_FS input hold after I <sup>2</sup> S_BCLK	0	—	ns

**Table 49. I<sup>2</sup>S slave mode timing (full voltage range)**

Num	Description	Min.	Max.	Unit
	Operating voltage	1.71	3.6	V
S11	I <sub>2</sub> S_BCLK cycle time (input)	$8 \times t_{SYS}$	—	ns
S12	I <sub>2</sub> S_BCLK pulse width high/low (input)	45%	55%	MCLK period
S13	I <sub>2</sub> S_FS input setup before I <sub>2</sub> S_BCLK	10	—	ns
S14	I <sub>2</sub> S_FS input hold after I <sub>2</sub> S_BCLK	3.5	—	ns
S15	I <sub>2</sub> S_BCLK to I <sub>2</sub> S_TXD/I <sub>2</sub> S_FS output valid	—	28.6	ns
S16	I <sub>2</sub> S_BCLK to I <sub>2</sub> S_TXD/I <sub>2</sub> S_FS output invalid	0	—	ns
S17	I <sub>2</sub> S_RXD setup before I <sub>2</sub> S_BCLK	10	—	ns
S18	I <sub>2</sub> S_RXD hold after I <sub>2</sub> S_BCLK	2	—	ns

## 6.9 Human-machine interfaces (HMI)

### 6.9.1 TSI electrical specifications

**Table 50. TSI electrical specifications**

Symbol	Description	Min.	Typ.	Max.	Unit	Notes
$V_{DDTSI}$	Operating voltage	1.71	—	3.6	V	
$C_{ELE}$	Target electrode capacitance range	1	20	500	pF	1
$f_{REFmax}$	Reference oscillator frequency	—	5.5	12.7	MHz	2
$f_{ELEmax}$	Electrode oscillator frequency	—	0.5	4.0	MHz	3
$C_{REF}$	Internal reference capacitor	0.5	1	1.2	pF	
$V_{DELTA}$	Oscillator delta voltage	100	600	760	mV	4
$I_{REF}$	Reference oscillator current source base current • 1uA setting (REFCHRG=0) • 32uA setting (REFCHRG=31)	—	1.133	1.5	µA	3 , 5
$I_{ELE}$	Electrode oscillator current source base current • 1uA setting (EXTCHRG=0) • 32uA setting (EXTCHRG=31)	—	1.133	1.5	µA	3 , 6
Pres5	Electrode capacitance measurement precision	—	8.3333	38400	fF/count	7
Pres20	Electrode capacitance measurement precision	—	8.3333	38400	fF/count	8
Pres100	Electrode capacitance measurement precision	—	8.3333	38400	fF/count	9
MaxSens	Maximum sensitivity	0.003	12.5	—	fF/count	10
Res	Resolution	—	—	16	bits	
$T_{Con20}$	Response time @ 20 pF	8	15	25	µs	11
$I_{TSI\_RUN}$	Current added in run mode	—	55	—	µA	
$I_{TSI\_LP}$	Low power mode current adder	—	1.3	2.5	µA	12

1. The TSI module is functional with capacitance values outside this range. However, optimal performance is not guaranteed.
2. CAPTRM=7, DELVOL=7, and fixed external capacitance of 20 pF.

121 MAP BGA	Pin Name	Default	ALT0	ALT1	ALT2	ALT3	ALT4	ALT5	ALT6	ALT7	EzPort
A11	NC	NC	NC								
B11	NC	NC	NC								
C11	NC	NC	NC								
K3	NC	NC	NC								
H4	NC	NC	NC								

## 8.2 K20 Pinouts

The below figure shows the pinout diagram for the devices supported by this document. Many signals may be multiplexed onto a single pin. To determine what signals can be used on which pin, see the previous section.